

<b>Notice of References Cited</b>	Application/Control No. 10/769,971		Applicant(s)/Patent Under Reexamination MADSEN ET AL.	
	Examiner Cynthia Britt		Art Unit 2117	Page 1 of 1

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*	B	US-6,005,894 A	12-1999	Kumar, Derek D.	375/270
*	C	US-6,028,845 A	02-2000	Serikawa et al.	370/249
*	D	US-6,351,500 B1	02-2002	Kumar, Derek D.	375/270
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	K	US-			
	L	US-			
	M	US-			

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	N	JP 03291588 A	12-1991	Japan	HORIUCHI, KENJI	
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	"Parameters tuning of HVDC small signal modulation controllers based on test signal" by Liu et al. Power Engineering Society General Meeting, 2003, IEEE Publication Date: 13-17 July 2003 Volume: 4, On page(s): - 2531 Vol. 4 ISBN: 0-7803-7989-6 INSPEC Accession Number: 7979163
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.